

## MOSFET – Power, Single, N-Channel

60 V, 1.36 mΩ, 250 A

#### NTMJS1D6N06CL

#### **Features**

- Small Footprint (5x6 mm) for Compact Design
- Low R<sub>DS(on)</sub> to Minimize Conduction Losses
- Low Q<sub>G</sub> and Capacitance to Minimize Driver Losses
- LFPAK8 Package, Industry Standard
- These Devices are Pb-Free and are RoHS Compliant

#### **MAXIMUM RATINGS** (T<sub>J</sub> = 25°C unless otherwise noted)

Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			$V_{DSS}$	60	V
Gate-to-Source Voltage			V <sub>GS</sub>	±20	V
Continuous Drain	Steady State	T <sub>C</sub> = 25°C	I <sub>D</sub>	250	Α
Current R <sub>θJC</sub> (Notes 1, 3)	State	T <sub>C</sub> = 100°C		175	
Power Dissipation		T <sub>C</sub> = 25°C	$P_{D}$	167	W
R <sub>θJC</sub> (Note 1)		T <sub>C</sub> = 100°C		83	
Continuous Drain Current R <sub>0.IA</sub>	Steady State	T <sub>A</sub> = 25°C	I <sub>D</sub>	38	Α
(Notes 1, 2, 3)	State	T <sub>A</sub> = 100°C		27	
Power Dissipation		T <sub>A</sub> = 25°C	$P_{D}$	3.8	W
R <sub>θJA</sub> (Notes 1, 2)		T <sub>A</sub> = 100°C		1.9	
Pulsed Drain Current	$T_A = 25^{\circ}C, t_p = 10 \ \mu s$		I <sub>DM</sub>	900	Α
Operating Junction and Storage Temperature Range			T <sub>J</sub> , T <sub>stg</sub>	-55 to +175	°C
Source Current (Body Diode)			IS	164	Α
Single Pulse Drain-to-Source Avalanche Energy (I <sub>L(pk)</sub> = 17 A)			E <sub>AS</sub>	451	mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			TL	260	°C

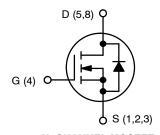
Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

#### THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case - Steady State	$R_{\theta JC}$	0.9	°C/W
Junction-to-Ambient - Steady State (Note 2)	$R_{\theta JA}$	36	

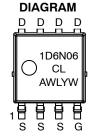
- The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.
- 2. Surface-mounted on FR4 board using a 650 mm², 2 oz. Cu pad.
- Maximum current for pulses as long as 1 second is higher but is dependent on pulse duration and duty cycle.

V <sub>(BR)DSS</sub>	R <sub>DS(ON)</sub> MAX	I <sub>D</sub> MAX
60 V	1.36 mΩ @ 10 V	250 A
00 V	2.30 m $\Omega$ @ 4.5 V	250 A



**N-CHANNEL MOSFET** 





**MARKING** 

1D6N06CL = Specific Device Code

A = Assembly Location

WL = Wafer Lot
 Y = Year
 W = Work Week

#### ORDERING INFORMATION

See detailed ordering, marking and shipping information on page 5 of this data sheet.

#### **ELECTRICAL CHARACTERISTICS** ( $T_J = 25^{\circ}C$ unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS							•
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		60			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> /				11		mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>GS</sub> = 0 V,	T <sub>J</sub> = 25°C			10	μΑ
		V <sub>DS</sub> = 60 V	T <sub>J</sub> = 125°C			250	1
Gate-to-Source Leakage Current	I <sub>GSS</sub>	V <sub>DS</sub> = 0 V, V <sub>GS</sub> = ±16 V				±100	nA
ON CHARACTERISTICS (Note 4)							
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}, I_D = 250 \mu A$		1.2		2.0	V
Threshold Temperature Coefficient	V <sub>GS(TH)</sub> /T <sub>J</sub>	·			-5.2		mV/°C
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V	I <sub>D</sub> = 50 A		1.13	1.36	mΩ
		V <sub>GS</sub> = 4.5 V	I <sub>D</sub> = 50 A		1.65	2.30	1
Forward Transconductance	9 <sub>FS</sub>	V <sub>DS</sub> =15 V, I <sub>D</sub> = 50 A			151		S
CHARGES, CAPACITANCES & GATE RE	SISTANCE						•
Input Capacitance	C <sub>ISS</sub>	V <sub>GS</sub> = 0 V, f = 1 MHz, V <sub>DS</sub> = 25 V			6660		pF
Output Capacitance	Coss				2953		1
Reverse Transfer Capacitance	C <sub>RSS</sub>				45		1
Total Gate Charge	Q <sub>G(TOT)</sub>	V <sub>GS</sub> = 4.5 V, V <sub>DS</sub> = 30 V; I <sub>D</sub> = 50 A			41		nC
Total Gate Charge	Q <sub>G(TOT)</sub>	V <sub>GS</sub> = 10 V, V <sub>DS</sub> = 30 V; I <sub>D</sub> = 50 A			91		1
Threshold Gate Charge	Q <sub>G(TH)</sub>	V <sub>GS</sub> = 4.5 V, V <sub>DS</sub> = 30 V; I <sub>D</sub> = 50 A			5		1
Gate-to-Source Charge	Q <sub>GS</sub>				17.1		1
Gate-to-Drain Charge	$Q_{GD}$				10.9		1
Plateau Voltage	$V_{GP}$				2.9		V
SWITCHING CHARACTERISTICS (Note	5)				•	•	•
Turn-On Delay Time	t <sub>d(ON)</sub>	$V_{GS}$ = 4.5 V, $V_{DS}$ = 30 V, $I_{D}$ = 50 A, $R_{G}$ = 1 $\Omega$			19		ns
Rise Time	t <sub>r</sub>				51		- - -
Turn-Off Delay Time	t <sub>d(OFF)</sub>				47		
Fall Time	t <sub>f</sub>				18		
DRAIN-SOURCE DIODE CHARACTERIS	STICS						
Forward Diode Voltage	$V_{SD}$	V <sub>GS</sub> = 0 V,	T <sub>J</sub> = 25°C		0.78	1.2	V
		I <sub>S</sub> = 50 A	T <sub>J</sub> = 125°C		0.66		1
Reverse Recovery Time	t <sub>RR</sub>	$V_{GS} = 0 \text{ V, } dI_{s}/dt = 100 \text{ A}/\mu s,$ $I_{S} = 50 \text{ A}$			78		ns
Charge Time	ta				36		1
Discharge Time	t <sub>b</sub>				42		1
Reverse Recovery Charge	Q <sub>RR</sub>				105		nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

4. Pulse Test: pulse width  $\leq 300~\mu s$ , duty cycle  $\leq 2\%$ .

5. Switching characteristics are independent of operating junction temperatures.

#### **TYPICAL CHARACTERISTICS**

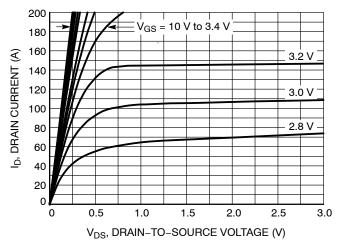


Figure 1. On-Region Characteristics

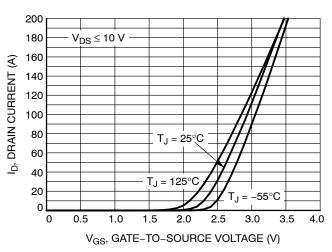


Figure 2. Transfer Characteristics

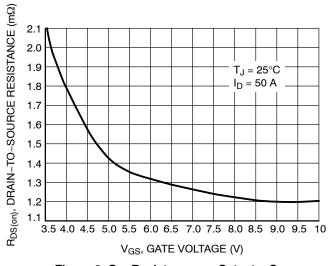


Figure 3. On-Resistance vs. Gate-to-Source Voltage

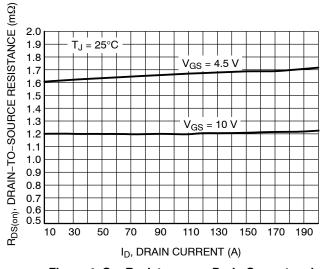


Figure 4. On-Resistance vs. Drain Current and Gate Voltage

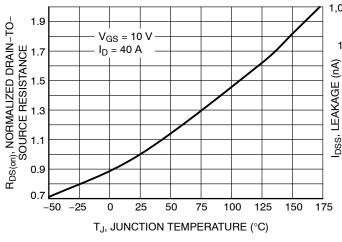


Figure 5. On–Resistance Variation with Temperature

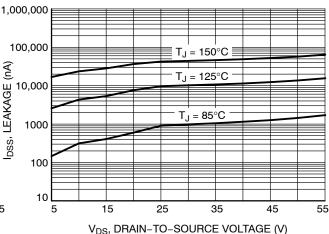


Figure 6. Drain-to-Source Leakage Current vs. Voltage

#### **TYPICAL CHARACTERISTICS**

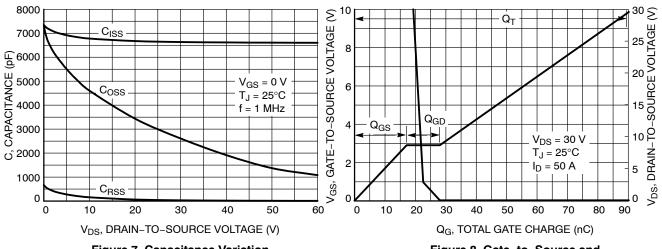


Figure 7. Capacitance Variation

Figure 8. Gate-to-Source and Drain-to-Source Voltage vs. Total Charge

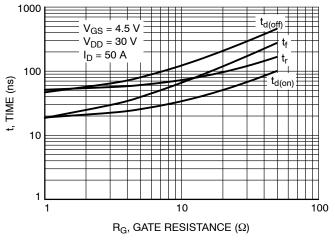


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

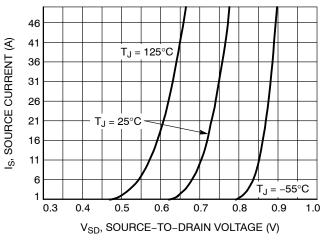


Figure 10. Diode Forward Voltage vs. Current

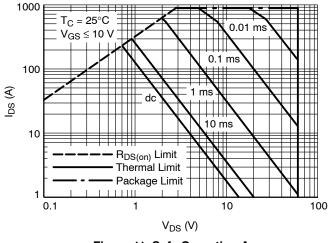


Figure 11. Safe Operating Area

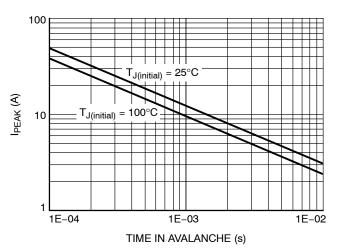


Figure 12. I<sub>PEAK</sub> vs. Time in Avalanche

#### **TYPICAL CHARACTERISTICS**

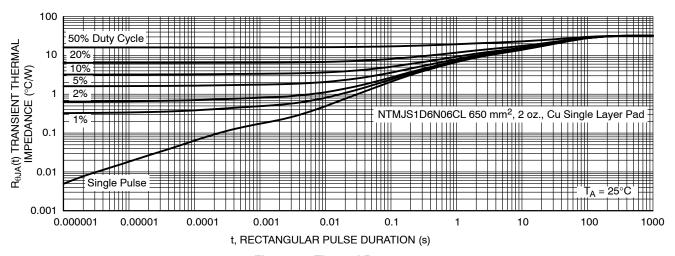


Figure 13. Thermal Response

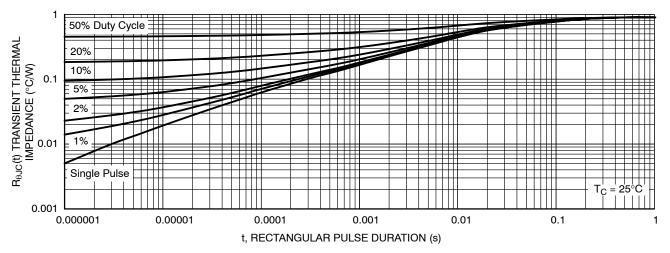


Figure 14. Thermal Response

#### **DEVICE ORDERING INFORMATION**

Device	Marking	Package	Shipping <sup>†</sup>
NTMJS1D6N06CLTWG	1D6N06CL	LFPAK8 (Pb-Free)	3000 / Tape & Reel

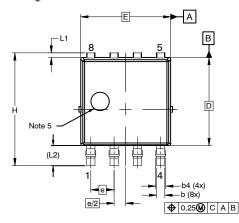
<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

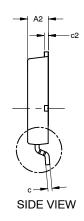




LFPAK8 4.90x4.80x1.12MM, 1.27P CASE 760AA ISSUE D

**DATE 22 APR 2024** 





#### NOTES:

- DIMENSIONING AND TOLERANCING PER ASME Y14.5M. 2018.
- 2. CONTROLLING DIMENSION: MILLIMETERS.
- DIMENSIONS D AND E DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR BURRS. MOLD FLASH PROTRUSIONS OR GATE BURRS SHALL NOT EXCEED 0.150mm PER SIDE.
- 4. DIMENSIONS D AND E ARE DETERMINED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY.

DIM

A A1

A2

А3

b

b4

С

c2

D

D1

D2

D3

D4

Ε

E1

E2

е

e/2

Н

L

L1

θ

**MILLIMETERS** 

1.20

0.08

1.15

0.25 BSC

0.55

0.22

0.22

4.80

4.00

3.08

0.40

0.65

4.90

5.15

3.96

1.27 BSC

0.635 BSC

0.25

4°

1.10 REF

6.15 6.30

0.70 0.90

0.45

NOM MAX

1.30

0.15

1.20

0.50

0.65

0.25

0.25

4.90

4.20

3.18

0.50

0.75

5.00

5.25

4.01

0.35

8°

MIN

1.10

0.00

1.10

0.40

0.45

0.19

0.19

4.70

3.80

2.98

0.30

0.55

4.80

5.05

3.91

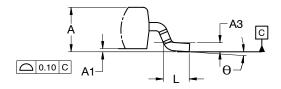
0.50

0.15

0°

5. OPTIONAL MOLD FEATURE.

#### **TOP VIEW**



DETAIL 'A'

# 

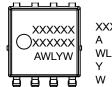


#### 4.51 4.06 5 0.70 1.15 1.15 1.27 4.51 0.70 1.06 1.06

RECOMMENDED LAND PAD

\*FOR ADDITIONAL INFORMATION ON OUR PB-FREE STRATEGY AND SOLDERING DETAILS, PLEASE DOWNLOAD THE ONSEMI SOLDERING AND MOUNTING TECHNIQUES REFERENCE MANUAL, SOLDERRM/D.

### GENERIC MARKING DIAGRAM\*



XXXXXX = Specific Device Code A = Assembly Location

A = Assembly Lot
WL = Wafer Lot
Y = Year
W = Work Week

\*This information is generic. Please refer to device data sheet for actual part marking. Some products may not follow the Generic Marking.

DOCUMENT NUMBER:

98AON82475G

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DESCRIPTION:

LFPAK8 4.90x4.80x1.12MM, 1.27P

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